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SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE TRADEMARK		ATTY DOCKET NO. 208387US2	SERIAL NO. 09/855,665		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Hideaki YAMAGATA, et al.					
		FILING DATE May 16, 2001	GROUP 2621				
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO	
	AO						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
15	AW	Whoi-Yul KIM, et al., IEEE, pages 391-396, "A PRACTICAL PATTERN RECOGNITION SYSTEM FOR TRANSLATION, SCALE AND ROTATION INVARIANCE", 1994					
15	AX	Hai LIN, et al., IEEE, pages 2963-2967, "CHINESE SIGNATURE VERIFICATION WITH MOMENT INVARIANTS", 1996					
15	AY	P. SANGASSAPAVIRIYA, et al., IEEE TENCON-Speech and Image Technologies for Computing and Telecommunications, pages 203-206, "SIMILARITY MEASURES FOR COMPRESSED IMAGE DATABASES", 1997					
	AZ						
Examiner 		Date Considered 5/64					
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through reference if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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## LIST OF REFERENCES CITED BY APPLICANT

ATTY DOCKET NO. 208387US2 | SERIAL NO. 09/855,665

APPLICANT Hideaki YAMAGATA, et al.

FILING DATE May 16, 2001 | GROUP 2621

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
1C	AA	5,796,869	08/18/98	M. TSUJI, et al.	382	203	
	AB						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	TRANSLATION NO
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## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

15	AW	A. ELEFTHERIADIS, et al., Signal Processing: Image Communication, vol. 7, no. 4, pages 435 - 455, "AUTOMATIC FACE LOCATION DETECTION FOR MODEL-ASSISTED RATE CONTROL IN H.261-COMPATIBLE CODING OF VIDEO", November 1, 1995
15	AX	S. KUMAR, et al., Pattern Recognition, vol. 27, no. 8, pages 1019 - 1028, "PARALLEL ALGORITHMS FOR CIRCLE DETECTION IN IMAGES", August 1, 1994
	AY	
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Examiner

Date Considered

5704

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 208387US2		SERIAL NO. NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Hideaki YAMAGATA, et al.			
		FILING DATE HEREWITH		GROUP			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
IS	AA	5,854,854	12/29/98	John F. CULLEN, et al.	382	176	12/29/98
IS	AB	5,642,106	06/24/97	Thomas R. HANCOCK, et al.	340	988	
IS	AC	4,748,676	05/31/88	Michiaki MIYAGAWA, et al.	382	288	
IS	AD	6,018,990	02/01/00	Nobuaki UEKI	73	104	
IS	AE	5,987,162	11/16/99	Masafumi NAKATA	382	152	
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IS	AO	11-110562	04/23/99	JAPAN (w/English Abstract) G 06 T 7/02	AS6226117	YES	-----
IS	AP	08-279021	10/22/96	JAPAN (w/English Abstract) G 0614 9/32	Mach. Trans.	NO	x
IS	AQ	09-147109	06/06/97	JAPAN (w/English Abstract) G 06 T 7/02	Mach. Trans.	NO	x
IS	AR	08-115022	05/07/96	JAPAN (w/English Abstract) G 6.3G, 21/04	Mach. Trans.	NO	*
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner	<i>John S.</i>				Date Considered 5704		

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